LCIE Laboratoire de Moirans Z.I. Centr'Alp 170, Rue de Chatagnon 38430 MOIRANS-FRANCE



CONDUCTED AND RADIATED MEASUREMENT PHOTO

FCCID: XKB-ICT250 IC: 2586D-ICT250CL

1.1 Conducted emission





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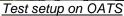


1.2 Radiated emissions

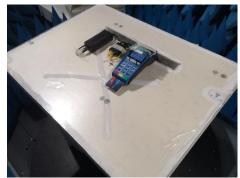






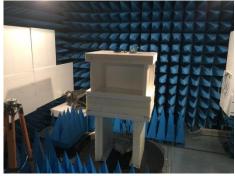








Test setup in anechoic chamber (9kHz to 1GHz)







Test setup in anechoic chamber (1GHz to 2GHz)